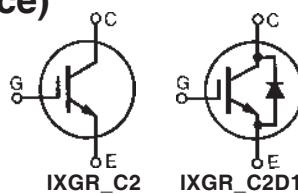


**HiPerFAST™ IGBT
ISOPLUS247™
C2-Class High Speed IGBTs
(Electrically Isolated Back Surface)**

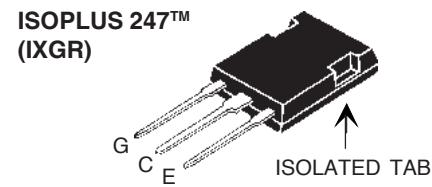
**IXGR 40N60C2
IXGR 40N60C2D1**

**V_{CES} = 600 V
 I_{C25} = 56 A
 $V_{CE(SAT)}$ = 2.7 V
 $t_{fi(typ)}$ = 32 ns**



Preliminary Data Sheet

Symbol	Test Conditions	Maximum Ratings		
V_{CES}	$T_J = 25^\circ\text{C}$ to 150°C	600	V	
V_{CGR}	$T_J = 25^\circ\text{C}$ to 150°C ; $R_{GE} = 1 \text{ M}\Omega$	600	V	
V_{GES}	Continuous	± 20	V	
V_{GEM}	Transient	± 30	V	
I_{C25}	$T_C = 25^\circ\text{C}$	56	A	
I_{C110}	$T_C = 110^\circ\text{C}$	26	A	
I_{D110}	$T_C = 110^\circ\text{C}$ (40N60C2D1)	27	A	
I_{CM}	$T_C = 25^\circ\text{C}$, 1 ms	200	A	
SSOA (RBSOA)	$V_{GE} = 15 \text{ V}$, $T_{VJ} = 125^\circ\text{C}$, $R_G = 10 \Omega$ Clamped inductive load @ $V_{CE} \leq 600 \text{ V}$	$I_{CM} = 80$	A	
P_c	$T_C = 25^\circ\text{C}$	170	W	
T_J		-55 ... +150	$^\circ\text{C}$	
T_{JM}		150	$^\circ\text{C}$	
T_{stg}		-55 ... +150	$^\circ\text{C}$	
Maximum Lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s		300	$^\circ\text{C}$	
V_{ISOL}	50/60 Hz, RMS, $t = 1 \text{ minute}$, $I_{ISOL} < 1 \text{ mA}$	2500	V~	
F_c	Mounting force	20..120/4.5..25	N/lb.	
Weight		4	g	



G = Gate C = Collector
E = Emitter

Features

- DCB Isolated mounting tab
- Meets TO-247AD package Outline
- High current handling capability
- Latest generation HDMOS™ process
- MOS Gate turn-on
 - drive simplicity

Applications

- Uninterruptible power supplies (UPS)
- Switched-mode and resonant-mode power supplies
- AC motor speed control
- DC servo and robot drives
- DC choppers

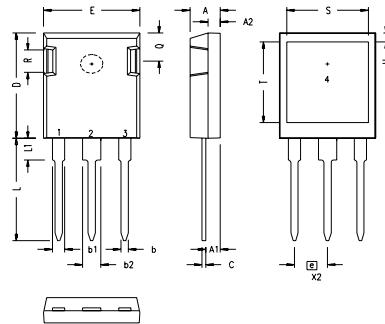
Advantages

- Easy assembly
- High power density
- Very fast switching speeds for high frequency applications

Symbol	Test Conditions	Characteristic Values		
		($T_J = 25^\circ\text{C}$ unless otherwise specified)	min.	typ.
BV_{CES}	$I_C = 250 \mu\text{A}$, $V_{GE} = 0 \text{ V}$	600		V
$V_{GE(th)}$	$I_C = 250 \mu\text{A}$, $V_{CE} = V_{GE}$	3.0		V
I_{CES}	$V_{CE} = V_{CES}$ $V_{GE} = 0 \text{ V}$	40N60C2 40N60C2/D1		$50 \mu\text{A}$ $100 \mu\text{A}$
I_{GES}	$V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$			$\pm 100 \text{ nA}$
$V_{CE(sat)}$	$I_C = 30 \text{ A}$, $V_{GE} = 15 \text{ V}$	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	2.2 2.0	2.7 V

Symbol	Test Conditions	Characteristic Values		
		$(T_J = 25^\circ C$ unless otherwise specified)		
		min.	typ.	max.
g_{fs}	$I_C = 30 A; V_{CE} = 10 V$, Pulse test, $t \leq 300 \mu s$, duty cycle $\leq 2\%$	20	36	S
C_{ies}	$V_{CE} = 25 V, V_{GE} = 0 V, f = 1 MHz$	2500	pF	
C_{oes}		180	pF	
C_{res}		220	pF	
C_{res}		54	pF	
Q_g	$I_C = 30 A, V_{GE} = 15 V, V_{CE} = 0.5 V_{CES}$	95	nC	
Q_{ge}		14	nC	
Q_{gc}		36	nC	
$t_{d(on)}$	Inductive load, $T_J = 25^\circ C$	18	ns	
t_{ri}		20	ns	
$t_{d(off)}$		90	140	ns
t_{fi}		32	ns	
E_{off}		0.20	0.37	mJ
$t_{d(on)}$	Inductive load, $T_J = 125^\circ C$	18	ns	
t_{ri}		20	ns	
E_{on}		0.3	mJ	
$t_{d(off)}$		0.6	mJ	
t_{fi}		130	ns	
E_{off}		80	240	ns
$R_{thJ-DCB}$	(Note 1)	0.26	K/W	
R_{thJC}		0.74	K/W	
R_{thCS}		0.15	K/W	

ISOPLUS 247 Outline



SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.190	.205	4.83	5.21
A1	.090	.100	2.29	2.54
A2	.075	.085	1.91	2.16
b	.045	.055	1.14	1.40
b1	.075	.084	1.91	2.13
b2	.115	.123	2.92	3.12
C	.024	.031	0.61	0.80
D	.819	.840	20.80	21.34
E	.620	.635	15.75	16.13
e	.215 BSC		5.45 BSC	
L	.780	.800	19.81	20.32
L1	.150	.170	3.81	4.32
Q	.220	.244	5.59	6.20
R	.170	.190	4.32	4.83
S	.520	.540	13.21	13.72
T	.620	.640	15.75	16.26
U	.065	.080	1.65	2.03

1 - GATE
2 - DRAIN (COLLECTOR)
3 - SOURCE (EMITTER)
4 - NO CONNECTION

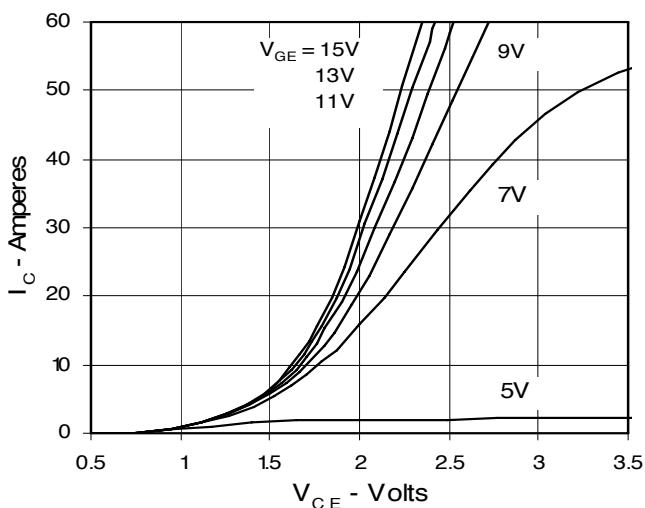
NOTE: This drawing will meet all dimensions requirement of JEDEC outline TO-247AD except screw hole.

Symbol	Test Conditions	Characteristic Values		
		$(T_J = 25^\circ C$ unless otherwise specified)	min.	typ.
V_F	$I_F = 30 A, V_{GE} = 0 V$, Pulse test $t \leq 300 \mu s$, duty cycle $d \leq 2\%$	$T_J = 150^\circ C$ $T_J = 25^\circ C$	1.6 2.5	V V
I_{RM}	$I_F = 30 A, V_{GE} = 0 V, -di/dt = 100 A/\mu s, T_J = 100^\circ C$ $V_R = 100 V$ $I_F = 1 A, -di/dt = 100 A/\mu s; V_R = 30 V$	100	4	A
t_{rr}		25	ns	ns
t_{rr}			ns	ns
R_{thJC}			1.5	K/W
R_{thCS}			0.15	K/W

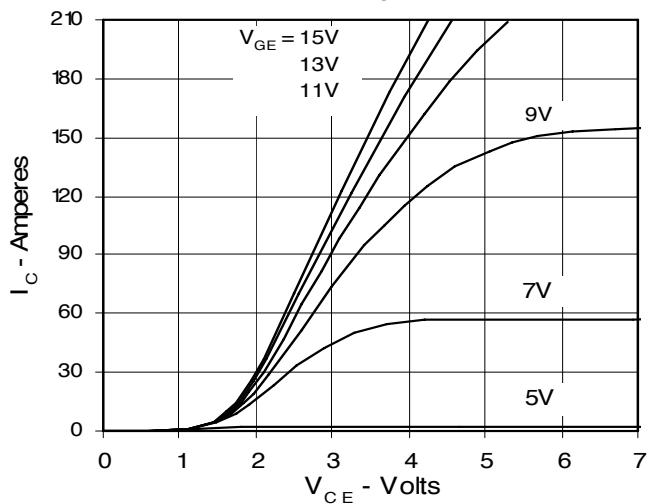
Notes:

1. $R_{thJ-DCB}$ is the thermal resistance junction-to-internal side of DCB substrate
2. R_{thJC} is the thermal resistance junction-to-external side of DCB substrate

**Fig. 1. Output Characteristics
@ 25 Deg. C**



**Fig. 2. Extended Output Characteristics
@ 25 deg. C**



**Fig. 3. Output Characteristics
@ 125 Deg. C**

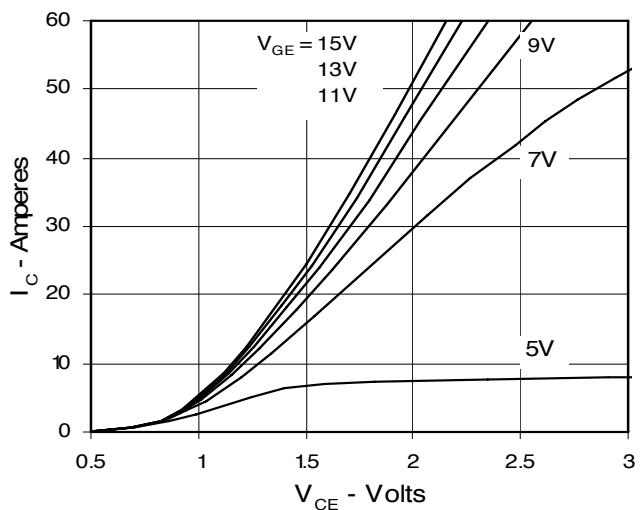
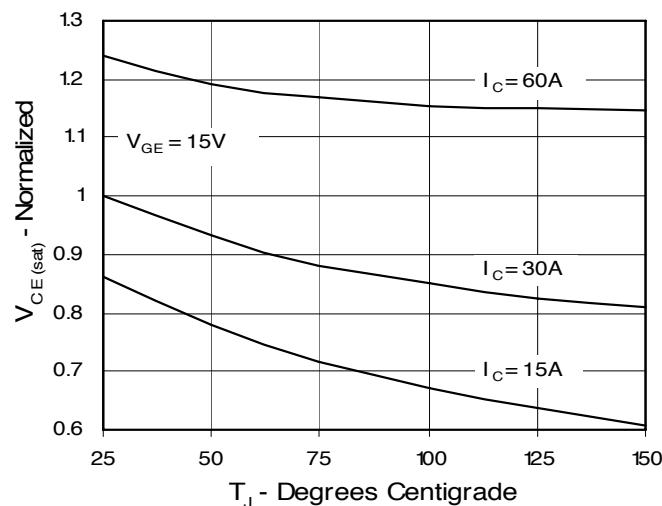


Fig. 4. Temperature Dependence of $V_{CE(sat)}$



**Fig. 5. Collector-to-Emitter Voltage
vs. Gate-to-Emitter voltage**

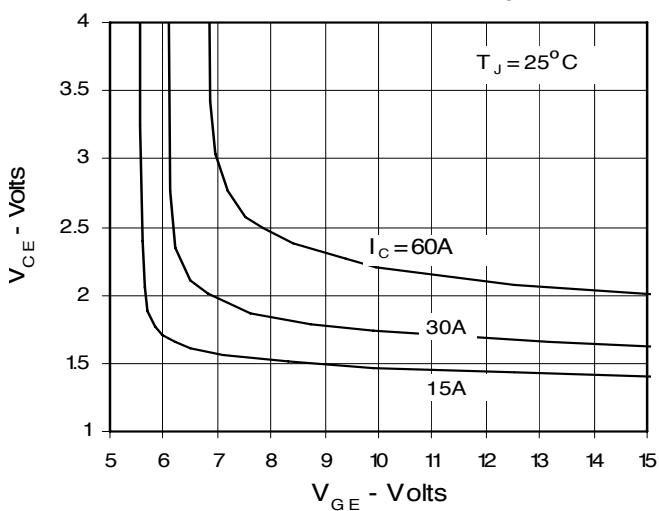


Fig. 6. Input Admittance

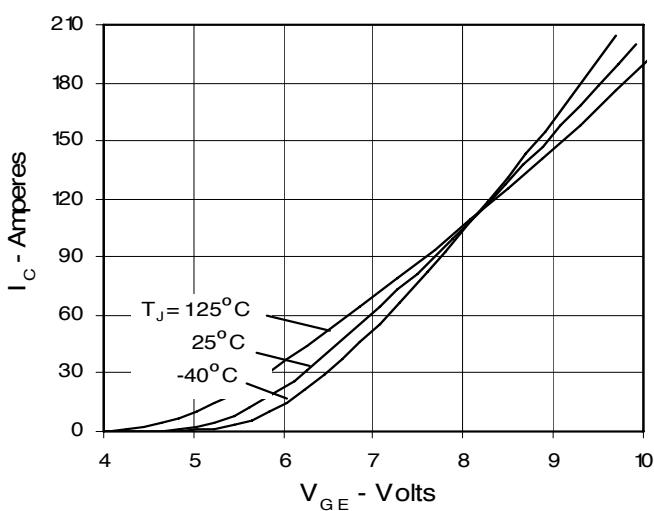


Fig. 7. Transconductance

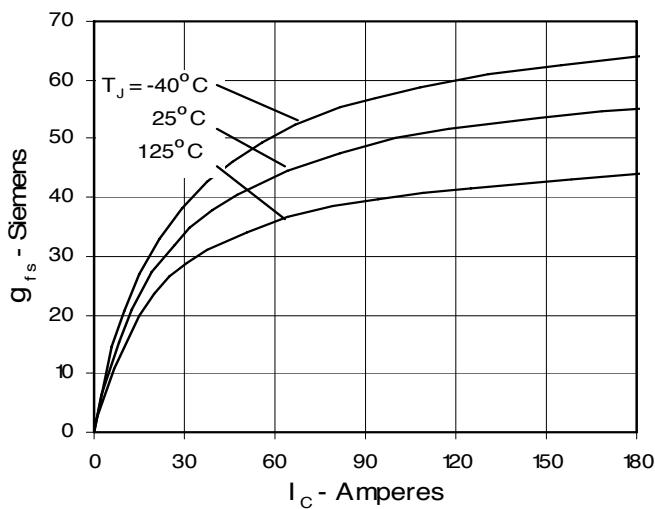


Fig. 8. Dependence of E_{off} on R_G

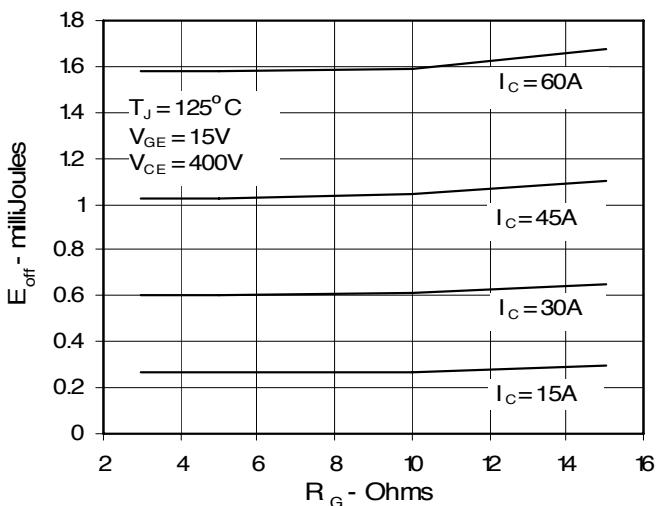


Fig. 9. Dependence of E_{off} on I_c

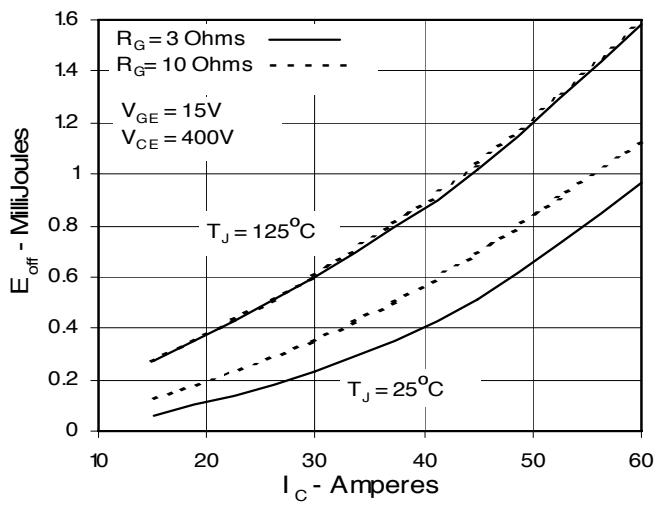


Fig. 10. Dependence of E_{off} on Temperature

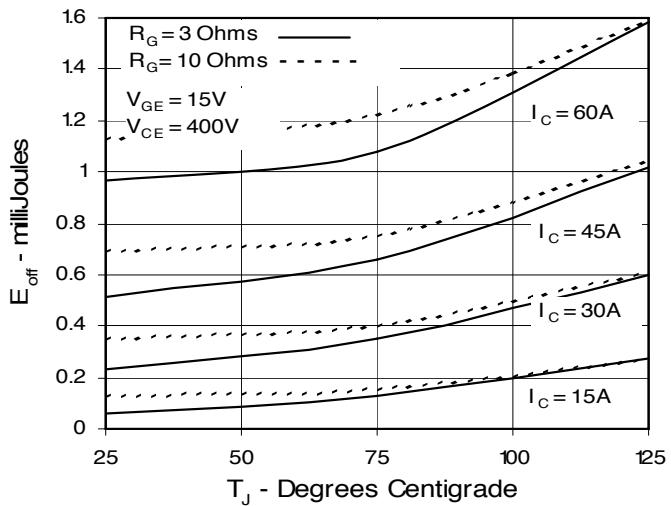


Fig. 11. Gate Charge

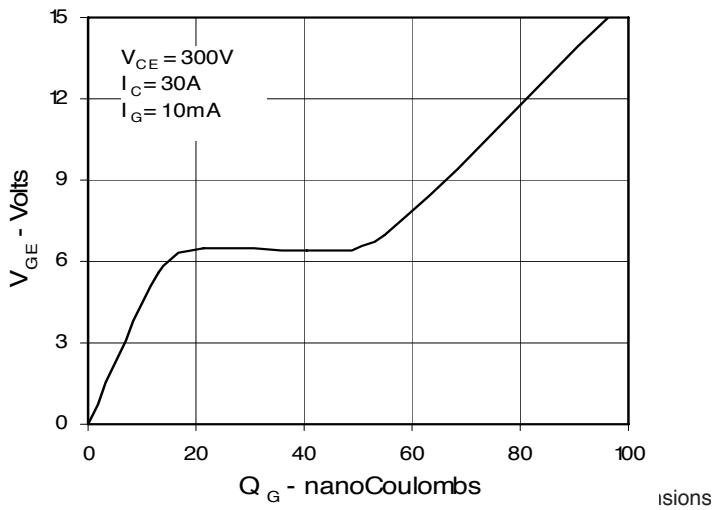


Fig. 12. Capacitance

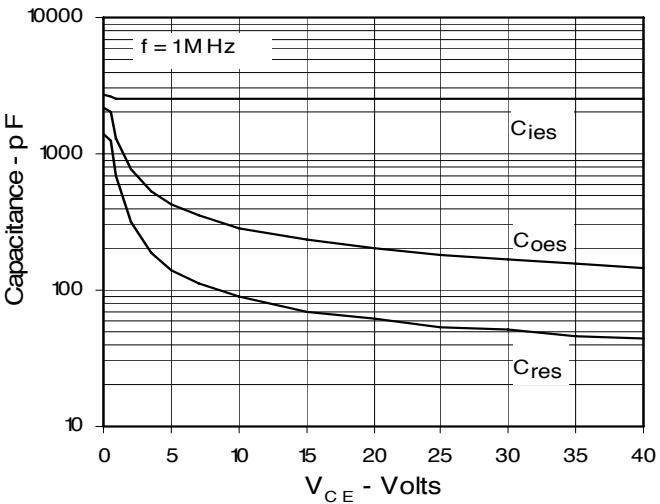
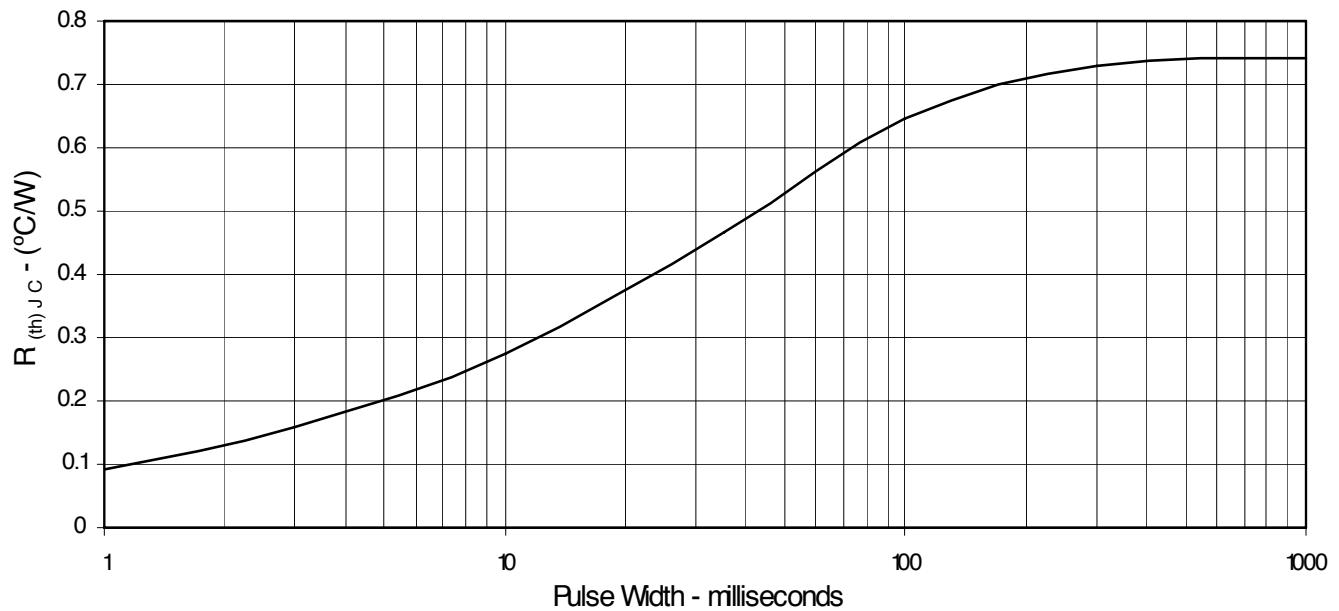


Fig. 13. Maximum Transient Thermal Resistance

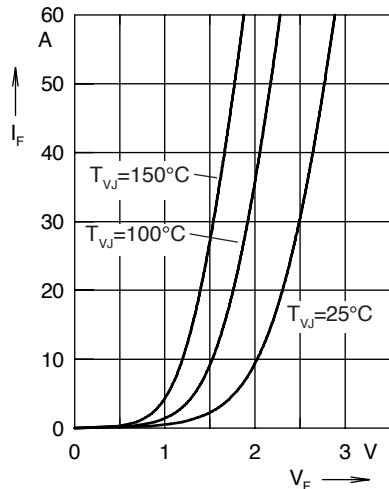


Fig. 14. Forward current I_F versus V_F

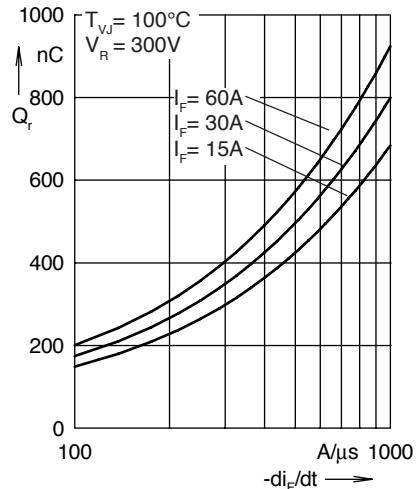


Fig. 15. Reverse recovery charge Q_r versus $-di_F/dt$

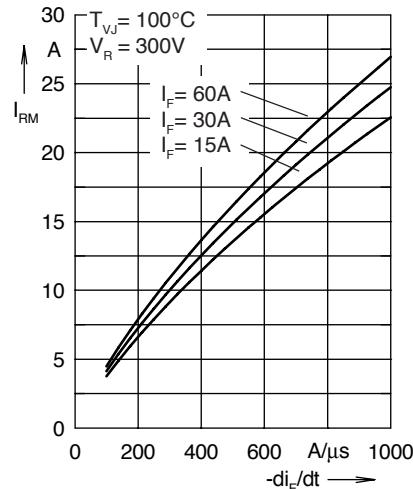


Fig. 16. Peak reverse current I_{RM} versus $-di_F/dt$

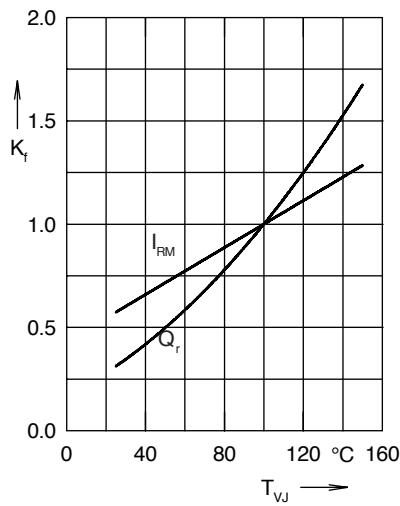


Fig. 17. Dynamic parameters Q_r , I_{RM} versus T_{VJ}

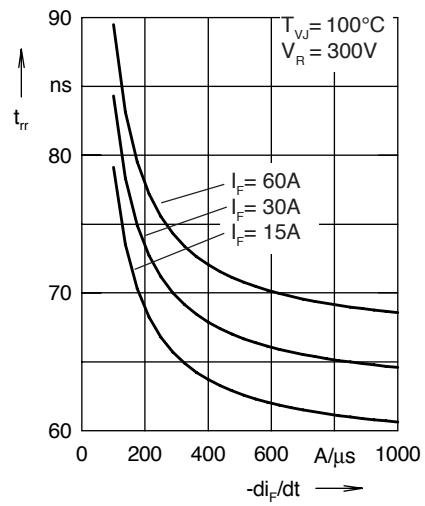


Fig. 18. Recovery time t_{rr} versus $-di_F/dt$

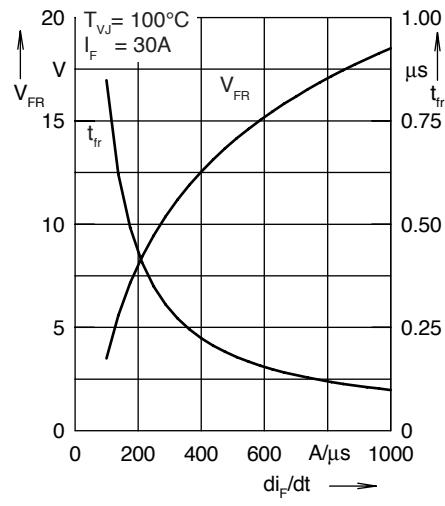


Fig. 19. Peak forward voltage V_{FR} and t_{rr} versus di_F/dt

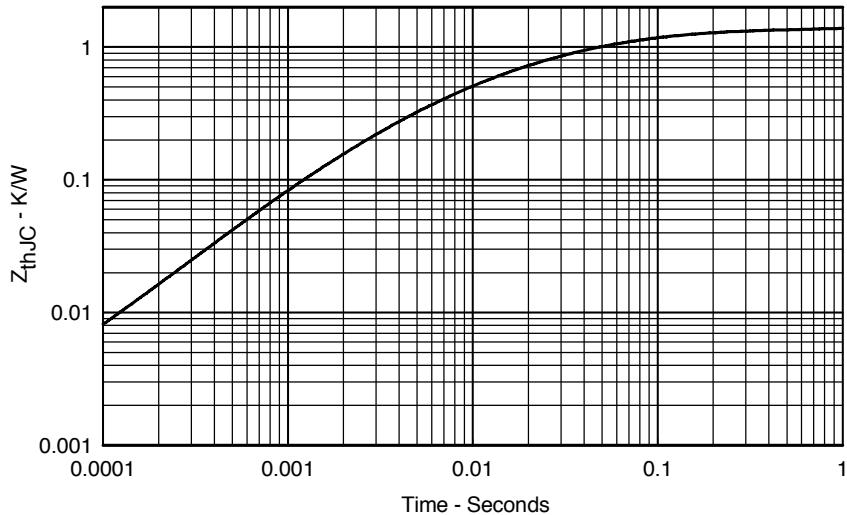


Fig. 20. Transient thermal resistance junction to case